











SN74AVC4T774

SCES693E - FEBRUARY 2008 - REVISED OCTOBER 2017

## SN74AVC4T774 4-Bit Dual-Supply Bus Transceiver With Configurable Voltage-Level Shifting and 3-State Outputs With Independent Direction Control Inputs

#### **Features**

- Each Channel Has an Independent DIR Control
- Control Inputs VIH/VIL Levels are Referenced to V<sub>CCA</sub> Voltage
- Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.2-V to 3.6-V Power-Supply Range
- I/Os are 4.6-V Tolerant
- Ioff Supports Partial Power-Down-Mode Operation
- Typical Data Rates
  - 380 Mbps (1.8-V to 3.3-V Translation)
  - 200 Mbps (<1.8-V to 3.3-V Translation)
  - 200 Mbps (Translate to 2.5 V or 1.8 V)
  - 150 Mbps (Translate to 1.5 V)
  - 100 Mbps (Translate to 1.2 V)
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds the Following Levels (Tested Per JESD 22)
  - ±8000-V Human-Body Model (A114-A)
  - 250-V Machine Model (A115-A)
  - ±1500-V Charged-Device Model (C101)

#### **Applications**

- Personal Electronic
- Industrial
- Enterprise
- Telecom

### 3 Description

This 4-bit noninverting bus transceiver uses two separate configurable power-supply rails. The A port is designed to track  $V_{\text{CCA}}.\ V_{\text{CCA}}$  accepts any supply voltage from 1.2 V to 3.6 V. The B port is designed to track V<sub>CCB</sub>. V<sub>CCB</sub> accepts any supply voltage from 1.2 to 3.6 V. The SN74AVC4T774 is optimized to operate with  $V_{CCA}/V_{CCB}$  set at 1.4 V to 3.6 V. It is operational with  $V_{CCA}/V_{CCB}$  as low as 1.2 V. This allows for universal low-voltage bi-directional between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V, and 3.3-V voltage nodes.

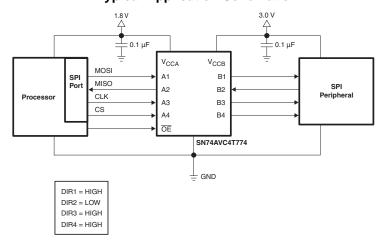
The SN74AVC4T774 is designed for asynchronous communication between data buses. The logic levels of the direction-control (DIR) input and the outputenable (OE) input activate either the B-port outputs or the A-port outputs or place both output ports in the high-impedance mode. The device transmits data from the A bus to the B bus when the B outputs are activated, and from the B bus to the A bus when the A outputs are activated. The input circuitry on both A and B ports is always active and must have a logic HIGH or LOW level applied to prevent excess I<sub>CC</sub> and

#### Device Information<sup>(1)</sup>

PART NUMBER	PACKAGE	BODY SIZE (NOM)
SN74AVC4T774PW	TSSOP (16)	5.00 mm × 4.40 mm
SN74AVC4T774RGY	VQFN (16)	4.00 mm × 3.50 mm
SN74AVC4T774RSV	UQFN (16)	2.60 mm × 1.80 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

#### **Typical Application Schematic**





## **Table of Contents**

1	Features 1	9 Detailed Description	17
2	Applications 1	9.1 Overview	17
3	Description 1	9.2 Functional Block Diagram	17
4	Revision History2	9.3 Feature Description	17
5	Description (continued)	9.4 Device Functional Modes	17
6	Pin Configuration and Functions 4	10 Application and Implementation	18
7	Specifications6	10.1 Application Information	18
•	7.1 Absolute Maximum Ratings	10.2 Typical Application	18
	7.2 ESD Ratings	11 Power Supply Recommendations	20
	7.3 Recommended Operating Conditions	12 Layout	20
	7.4 Thermal Information	12.1 Layout Guidelines	
	7.5 Electrical Characteristics T <sub>A</sub> = 25°C	12.2 Layout Example	
	7.6 Electrical Characteristics T <sub>A</sub> = -40°C to 85°C9	13 Device and Documentation Support	22
	7.7 Switching Characteristics $V_{CCA} = 1.2 \text{ V}$	13.1 Documentation Support	
	7.8 Switching Characteristics $V_{CCA} = 1.5 \text{ V} \pm 0.1 \text{ V} \dots 11$	13.2 Receiving Notification of Documentation Updat	tes 22
	7.9 Switching Characteristics $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V} \dots 12$	13.3 Community Resources	
	7.10 Switching Characteristics $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V} \dots 13$	13.4 Trademarks	22
	7.11 Switching Characteristics $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V} \dots 14$	13.5 Electrostatic Discharge Caution	22
	7.12 Typical Characteristics	13.6 Glossary	
8	Parameter Measurement Information 16	14 Mechanical, Packaging, and Orderable Information	

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

	or and the second of the secon	
С	hanges from Revision D (January 2015) to Revision E	Page
•	Added Storage junction temperature to Absolute Maximum Ratings	6
С	changes from Revision C (December 2014) to Revision D	Page
•	Changed Pin Functions table order for Pins B4, B3, B2 and B1	5
С	changes from Revision B (May 2008) to Revision C	Page
•	Added Pin Configuration and Functions section, ESD Ratings table, Feature Description section, Device Functional Modes, Application and Implementation section, Power Supply Recommendations section, Layout section, Device and Documentation Support section, and Mechanical, Packaging, and Orderable Information section	

Submit Documentation Feedback

Copyright © 2008–2017, Texas Instruments Incorporated



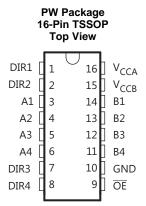
## 5 Description (continued)

The SN74AVC4T774 is designed so that the control pins (DIR1, DIR2, DIR3, DIR4, and  $\overline{OE}$ ) are supplied by  $V_{CCA}$ . This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down. The  $V_{CC}$  isolation feature ensures that if either  $V_{CC}$  input is at GND, then both ports are in the high-impedance state.

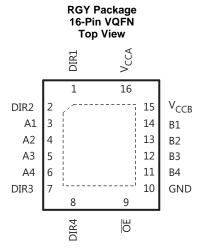
To ensure the high-impedance state during power-up or power-down,  $\overline{\text{OE}}$  should be tied to  $V_{\text{CCA}}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver. Since this device has CMOS inputs, it is very important to not allow them to float. If the inputs are not driven to either a high  $V_{\text{CC}}$  state, or a low-GND state, an undesirable larger than expected  $I_{\text{CC}}$  current may result. Since the input voltage settlement is governed by many factors (for example, capacitance, board-layout, package inductance, surrounding conditions, and so forth), ensuring that they these inputs are kept out of erroneous switching states and tying them to either a high or a low level minimizes the leakage-current.

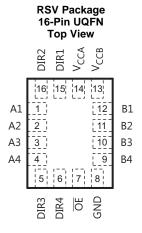


## 6 Pin Configuration and Functions



(1) Shown for a single channel







#### **Pin Functions**

	PIN			
NAME	PW RGY	RSV	I/O	DESCRIPTION
DIR1	1	15	I	Direction-control input referenced to $V_{\text{CCA}}$ , controls signal flow for the first (A1/B1) I/O channels
DIR2	2	16	I	Direction-control input referenced to $V_{\text{CCA}}$ , controls signal flow for the second (A2/B2) I/O channels
A1	3	1	I/O	Input/output A1. Referenced to V <sub>CCA</sub>
A2	4	2	I/O	Input/output A2. Referenced to V <sub>CCA</sub>
A3	5	3	I/O	Input/output A3. Referenced to V <sub>CCA</sub>
A4	6	4	I/O	Input/output A4. Referenced to V <sub>CCA</sub>
DIR3	7	5	I	Direction-control input referenced to $V_{\text{CCA}}$ , controls signal flow for the third (A3/B3) I/O channels
DIR4	8	6	I	Direction-control input referenced to $V_{\text{CCA}}$ , controls signal flow for the fourth (A4/B4) I/O channels
ŌĒ	9	7	I	3-state output-mode enables. Pull $\overline{\text{OE}}$ high to place all outputs in 3-state mode. Referenced to $V_{\text{CCA}}$ .
GND	10	8	_	Ground
B4	11	9	I/O	Input/output B4. Referenced to V <sub>CCB</sub>
В3	12	10	I/O	Input/output B3. Referenced to V <sub>CCB</sub>
B2	13	11	I/O	Input/output B2. Referenced to V <sub>CCB</sub>
B1	14	12	I/O	Input/output B1. Referenced to V <sub>CCB</sub>
V <sub>CCB</sub>	15	13	_	B-port supply voltage. 1.2 V ≤ V <sub>CCB</sub> ≤ 3.6 V
V <sub>CCA</sub>	16	14	_	A-port supply voltage. 1.2 V ≤ V <sub>CCA</sub> ≤ 3.6 V

Submit Documentation Feedback



## 7 Specifications

#### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

			MIN	MAX	UNIT
$V_{CCA} V_{CCB}$	Supply voltage		-0.5	4.6	V
		I/O ports (A port)	-0.5	4.6	
$V_{I}$	Input voltage <sup>(2)</sup>	I/O ports (B port)	-0.5	4.6	V
	Voltage applied to any output in the high-impedance or power-off state (2)	Control inputs	-0.5	4.6	
.,	Voltage applied to any output in the high-impedance or power-of state (2)	A port	-0.5	4.6	
Vo	state <sup>(2)</sup>	B port	-0.5	4.6	V
.,	(0) (0)	A port	-0.5	V <sub>CCA</sub> + 0.5	V
Vo	Voltage applied to any output in the high or low state (2)(3)	B port	-0.5	V <sub>CCB</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>I</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Io	Continuous output current			±50	mA
	Continuous current through V <sub>CCA</sub> , V <sub>CCB</sub> , or GND			±100	mA
TJ	Storage junction temperature			150	°C
T <sub>stg</sub>	Storage temperature		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 7.2 ESD Ratings

			VALUE	UNIT
		Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±8000	
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1500	V
		Machine Model (A115-A)	250	

<sup>(1)</sup> JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

Submit Documentation Feedback

Copyright © 2008–2017, Texas Instruments Incorporated

<sup>(2)</sup> The input voltage and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> The output positive-voltage rating may be exceeded up to 4.6 V maximum if the output current rating is observed.

<sup>(2)</sup> JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



#### 7.3 Recommended Operating Conditions

See (1)(2)(3)

			V <sub>cci</sub>	V <sub>cco</sub>	MIN	MAX	UNIT	
V <sub>CCA</sub>	Supply voltage				1.2	3.6	V	
V <sub>CCB</sub>	Supply voltage				1.2	3.6	V	
			1.2 V to 1.95 V		V <sub>CCI</sub> × 0.65			
$V_{IH}$	High-level input voltage	Data inputs (4)	1.95 V to 2.7 V		1.6		V	
	input voltage		2.7 V to 3.6 V		2			
			1.2 V to 1.95 V			V <sub>CCI</sub> × 0.35		
$V_{IL}$	Low-level input voltage	Data inputs <sup>(4)</sup>	1.95 V to 2.7 V			0.7	V	
	input voltage		2.7 V to 3.6 V			0.8		
		DIR	1.2 V to 1.95 V		V <sub>CCA</sub> × 0.65			
$V_{IH}$	High-level input voltage	(referenced to V <sub>CCA</sub> ) <sup>(5)</sup>	1.95 V to 2.7 V		1.6		V	
	input voltage	(DIRx, OE)	2.7 V to 3.6 V		2			
	Low-level input voltage		DIR	1.2 V to 1.95 V			$V_{CCA} \times 0.35$	
$V_{IL}$		(referenced to V <sub>CCA</sub> ) <sup>(5)</sup>	1.95 V to 2.7 V			0.7	V	
		(DIRx, OE)	2.7 V to 3.6 V			0.8		
$V_{I}$	Input voltage				0	3.6	V	
\/	Output valtage	Active state			0	V <sub>cco</sub>	V	
$V_O$	Output voltage	3-state			0	3.6	V	
				1.1 V to 1.2 V		-3		
				1.4 V to 1.6 V		-6		
$I_{OH}$	High-level output c	urrent		1.65 V to 1.95 V		-8	mA	
				2.3 V to 2.7 V		-9		
				3 V to 3.6 V		-12		
				1.1 V to 1.2 V		3		
				1.4 V to 1.6 V		6		
$I_{OL}$	Low-level output co	urrent		1.65 V to 1.95 V		8	mA	
				2.3 V to 2.7 V		9		
				3 V to 3.6 V		12		
Δt/Δν	Input transition rise	e or fall rate				5	ns/V	
T <sub>A</sub>	Operating free-air	temperature			-40	85	°C	

- $V_{CCI}$  is the  $V_{CC}$  associated with the input port.  $V_{CCO}$  is the  $V_{CC}$  associated with the output port. All unused data inputs of the device must be held at  $V_{CCI}$  or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004. For  $V_{CCI}$  values not specified in the data sheet,  $V_{IH}$  min =  $V_{CCI} \times 0.7$  V,  $V_{IL}$  max =  $V_{CCI} \times 0.3$  V For  $V_{CCA}$  values not specified in the data sheet,  $V_{IH}$  min =  $V_{CCA} \times 0.7$  V,  $V_{IL}$  max =  $V_{CCA} \times 0.3$  V

#### 7.4 Thermal Information

			SN74AVC4T774	ļ	
	THERMAL METRIC <sup>(1)</sup>	PW	RGY	RSV	UNIT
		16 PINS	16 PINS	16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	118.2	37.7	139.2	
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	52.8	56.1	64.9	
$R_{\theta JB}$	Junction-to-board thermal resistance	63.3	15.9	67.7	°C/W
ΨЈТ	Junction-to-top characterization parameter	8.8	0.5	1.7	C/VV
ΨЈВ	Junction-to-board characterization parameter	62.7	16.1	67.4	
R <sub>0</sub> JC(bot)	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



## 7.5 Electrical Characteristics $T_A = 25$ °C

over recommended operating free-air temperature range (unless otherwise noted) (1)(2)(3)

PA	RAMETER	TEST COND	ITIONS	V <sub>CCA</sub>	V <sub>CCB</sub>	MIN	TYP	MAX	UNIT
		$I_{OH} = -100 \mu A$		1.2 V to 3.6 V	1.2 V to 3.6 V				
		$I_{OH} = -3 \text{ mA}$		1.2 V	1.2 V		0.95		
V <sub>OH</sub>		$I_{OH} = -6 \text{ mA}$	V V	1.4 V	1.4 V				V
VOH		$I_{OH} = -8 \text{ mA}$	$V_I = V_{IH}$	1.65 V	1.65 V				V
		$I_{OH} = -9 \text{ mA}$		2.3 V	2.3 V				
		$I_{OH} = -12 \text{ mA}$		3 V	3 V				
		$I_{OL} = 100 \mu A$		1.2 V to 3.6 V	1.2 V to 3.6 V				
		$I_{OL} = 3 \text{ mA}$		1.2 V	1.2 V		0.25		
V <sub>OL</sub>	$I_{OL} = 6 \text{ mA}$	V V	1.4 V	1.4 V				V	
	$I_{OL} = 8 \text{ mA}$	$V_I = V_{IL}$	1.65 V	1.65 V				V	
		$I_{OL} = 9 \text{ mA}$		2.3 V	2.3 V				
		$I_{OL} = 12 \text{ mA}$		3 V	3 V				
I <sub>I</sub>		$V_I = V_{CCA}$ or GND	V <sub>I</sub> = V <sub>CCA</sub> or GND		1.2 V to 3.6 V		±0.025	±0.25	μΑ
	A == D ====	\\ -=\\ \ 0 to 0 C\	,	0 V	0 V to 3.6 V		±0.1	±1	۸
l <sub>off</sub>	A or B port	$V_1 \text{ or } V_0 = 0 \text{ to } 3.6  V_0$	/	0 V to 3.6 V	0 V		±0.1	±1	μΑ
l <sub>OZ</sub>	A or B port	$V_O = V_{CCO}$ or $GND_{\underline{O}}$ $V_I = V_{CCI}$ or $GND_{\underline{O}}$	DE = V <sub>IH</sub>	3.6 V	3.6 V		±0.5	±2.5	μΑ
	•			1.2 V to 3.6 V	1.2 V to 3.6 V				
$I_{CCA}$		$V_I = V_{CCI}$ or GND, $I_C$	0 = 0	0 V	0 V to 3.6 V				μА
				0 V to 3.6 V	0 V				
				1.2 V to 3.6 V	1.2 V to 3.6 V				
$I_{CCB}$		$V_I = V_{CCI}$ or GND, $I_C$	0 = 0	0 V	0 V to 3.6 V				μΑ
				0 V to 3.6 V	0 V				
I <sub>CCA</sub> +	I <sub>CCB</sub>	$V_I = V_{CCI}$ or GND, $I_C$	0 = 0	1.2 V to 3.6 V	1.2 V to 3.6 V				μΑ
Ci	Control inputs	V <sub>I</sub> = 3.3 V or GND		3.3 V	3.3 V		2.5		pF
C <sub>io</sub>	A or B port	$V_O = 3.3 \text{ V or GND}$		3.3 V	3.3 V		5		pF

<sup>(1)</sup> All unused control inputs of the device must be held at VCC or GND to ensure proper device operation. Refer to Implications of Slow or Floating CMOS Inputs Application Report

(2)  $V_{CCO}$  is the  $V_{CC}$  associated with the output port.

(3)  $V_{CCI}$  is the  $V_{CC}$  associated with the input port.

Submit Documentation Feedback

Copyright © 2008–2017, Texas Instruments Incorporated



## 7.6 Electrical Characteristics $T_A = -40^{\circ}C$ to 85°C

over recommended operating free-air temperature range (unless otherwise noted)(1)(2)(3)

PA	RAMETER	TEST CONDI	TIONS	V <sub>CCA</sub>	V <sub>CCB</sub>	MIN	TYP	MAX	UNIT
		$I_{OH} = -100 \mu A$		1.2 V to 3.6 V	1.2 V to 3.6 V	V <sub>CCO</sub> - 0.2			
		$I_{OH} = -3 \text{ mA}$		1.2 V	1.2 V				
V <sub>OH</sub>	$I_{OH} = -6 \text{ mA}$	., .,	1.4 V	1.4 V	1.05				
۷ОН		$I_{OH} = -8 \text{ mA}$	$V_I = V_{IH}$	1.65 V	1.65 V	1.2			V
		$I_{OH} = -9 \text{ mA}$		2.3 V	2.3 V	1.75			
		I <sub>OH</sub> = -12 mA		3 V	3 V	2.3			
		I <sub>OL</sub> = 100 μA		1.2 V to 3.6 V	1.2 V to 3.6 V			0.2	
		I <sub>OL</sub> = 3 mA		1.2 V	1.2 V				
$V_{OL}$	I <sub>OL</sub> = 6 mA	., .,	1.4 V	1.4 V			0.35	\ /	
	I <sub>OL</sub> = 8 mA	$V_I = V_{IL}$	1.65 V	1.65 V			0.45	V	
		I <sub>OL</sub> = 9 mA		2.3 V	2.3 V			0.55	
		I <sub>OL</sub> = 12 mA 3 V	3 V			0.7			
ı	Control inputs	$V_I = V_{CCA}$ or GND		1.2 V to 3.6 V	1.2 V to 3.6 V	±		±1	μА
		V V 04 00V		0 V	0 V to 3.6 V			±5	
off	A or B port	$V_I$ or $V_O = 0$ to 3.6 V		0 V to 3.6 V	0 V			±5	μА
loz	A or B port	$V_O = V_{CCO}$ or $GND$ , $V_I = V_{CCI}$ or $GND$ , $OE$	= V <sub>IH</sub>	3.6 V	3.6 V			±5	μА
	*			1.2 V to 3.6 V	1.2 V to 3.6 V			8	
CCA		$V_I = V_{CCI}$ or GND, $I_O$	= 0	0 V	0 V to 3.6 V			-2	μΑ
				0 V to 3.6 V	0 V			8	
				1.2 V to 3.6 V	1.2 V to 3.6 V			8	
ССВ		$V_I = V_{CCI}$ or GND, $I_O$	= 0	0 V	0 V to 3.6 V			8	μΑ
				0 V to 3.6 V	0 V			-2	
I <sub>CCA</sub> + I <sub>CCB</sub> V <sub>I</sub> =		$V_I = V_{CCI}$ or GND, $I_O$	= 0	1.2 V to 3.6 V	1.2 V to 3.6 V			16	μΑ
C <sub>i</sub>	Control inputs	V <sub>I</sub> = 3.3 V or GND		3.3 V	3.3 V			3	pF
C <sub>io</sub>	A or B port	$V_O = 3.3 \text{ V or GND}$		3.3 V	3.3 V			6	pF

 $V_{CCI}$  is the  $V_{CC}$  associated with the input port.  $V_{CCO}$  is the  $V_{CC}$  associated with the output port. All unused control inputs of the device must be held at VCC or GND to ensure proper device operation. Refer to *Implications of Slow or Floating CMOS Inputs Application Report*.



## 7.7 Switching Characteristics $V_{CCA} = 1.2 \text{ V}$

over recommended operating free-air temperature range,  $V_{CCA} = 1.2 \text{ V}$  (unless otherwise noted) (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	ТҮР	UNIT	
			V <sub>CCB</sub> = 1.2 V	3.5		
				V <sub>CCB</sub> = 1.5 V ± 0.1 V	2.8	
PLH PHL	Α	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	2.7	ns	
PHL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	2.7		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	3.1		
			V <sub>CCB</sub> = 1.2 V	3.8		
			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	3.4		
PLH PHL	В	Α	$V_{CCB} = 1.8 \text{ V} \pm 0.15 \text{ V}$	3.2	ns	
PHL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	3		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	2.9		
			V <sub>CCB</sub> = 1.2 V	6		
	ŌĒ			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	4.8	
PZH PZL		DE A	V <sub>CCB</sub> = 1.8 V ± 0.15 V	4.4	ns	
PZL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	5.3		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	9.3		
		V <sub>CCB</sub> = 1.2 V	6.7			
			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	6.7		
PZH PZL	ŌĒ	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	6.6	ns	
PZL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	6.7		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	6.6		
			V <sub>CCB</sub> = 1.2 V	4.3		
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	3.6		
PHZ	ŌĒ	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	3.7	ns	
PLZ			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	3.3		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	4		
			V <sub>CCB</sub> = 1.2 V	4.4		
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	4.4	ns	
PHZ	ŌĒ	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	4.4		
PLZ			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	4.4		
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	4.4		

Submit Documentation Feedback



## 7.8 Switching Characteristics $V_{CCA} = 1.5 V \pm 0.1 V$

over recommended operating free-air temperature range,  $V_{CCA}$  = 1.5 V ± 0.1 V (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
			V <sub>CCB</sub> = 1.2 V		3.1		
t <sub>PLH</sub> t <sub>PHL</sub>			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.3		4.4	
	Α	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.2		3.9	ns
PHL			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		3.6	
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		3.9	
			V <sub>CCB</sub> = 1.2 V		2.9		
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.6		5.1	
t <sub>PLH</sub>	В	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.4		4.9	ns
t <sub>PHL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.2		4.6	
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		4.5	
			V <sub>CCB</sub> = 1.2 V		5.3		
	ŌĒ		V <sub>CCB</sub> = 1.5 V ± 0.1 V	1.1		7.1	
t <sub>PZH</sub>		A	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.9		6.2	ns
t <sub>PZL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.7		5.5	
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		6.4	
			V <sub>CCB</sub> = 1.2 V		4.4		
	ŌĒ		V <sub>CCB</sub> = 1.5 V ± 0.1 V	1.1		8.2	ns
t <sub>PZH</sub>		В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	1.1		8.2	
t <sub>PZL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	1.1		8.2	
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	1.1		8.2	
			V <sub>CCB</sub> = 1.2 V		3.6		
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	1.2		4.8	
t <sub>PHZ</sub>	ŌĒ	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.8		5.4	ns
t <sub>PLZ</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.4		5.1	
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	1		5.4	
			V <sub>CCB</sub> = 1.2 V		3.1		
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.3		5.6	
t <sub>PHZ</sub>	<del>OE</del> B	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.2		5.7	ns
t <sub>PLZ</sub>		V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.3		5.6		
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.3		56	

Copyright © 2008–2017, Texas Instruments Incorporated



## 7.9 Switching Characteristics $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$

over recommended operating free-air temperature range,  $V_{CCA} = 1.8 \text{ V} \pm 0.15 \text{ V}$  (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
			V <sub>CCB</sub> = 1.2 V		2.8					
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		4.1				
PLH	Α	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		3.6	ns			
t <sub>PHL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		3.1				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		3.3				
			V <sub>CCB</sub> = 1.2 V		2.6					
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.4		4.3				
PLH PHL	В	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		4.1	ns			
PHL			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		3.8				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		3.7				
	ŌĒ		V <sub>CCB</sub> = 1.2 V		5					
		А	$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	0.8		6.7				
PZH PZL			V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.6		5.8	ns			
PZL			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.4		4.8				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.3		4.6				
	ŌĒ		V <sub>CCB</sub> = 1.2 V		3.3					
			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	0.2		6.7	ns			
PZH PZL		В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.2		6.6				
PZL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	0.2		6.7				
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	0.2		6.7				
			V <sub>CCB</sub> = 1.2 V		3.4					
			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	0.7		4.7				
PHZ PLZ	ŌĒ	Α	$V_{CCB} = 1.8 \text{ V} \pm 0.15 \text{ V}$	0.3		5.1	ns			
PLZ			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	0.1		4.5				
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	0.8		5				
			V <sub>CCB</sub> = 1.2 V		2.9					
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		5.7				
PHZ	ŌĒ	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		5.8	ns			
FLL			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	0.1		5.8				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		5.8				

Submit Documentation Feedback

Copyright © 2008–2017, Texas Instruments Incorporated



## 7.10 Switching Characteristics $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$

over recommended operating free-air temperature range,  $V_{CCA} = 2.5 \text{ V} \pm 0.2 \text{ V}$  (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT			
			V <sub>CCB</sub> = 1.2 V		2.6					
t <sub>PLH</sub> t <sub>PHL</sub>			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		3.8				
	Α	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		3.2	ns			
			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		2.7				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		2.6				
			V <sub>CCB</sub> = 1.2 V		2.5					
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.5		3.4				
PLH PHL	В	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.2		3.1	ns			
PHL			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		2.8				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		2.6				
			V <sub>CCB</sub> = 1.2 V		4.7					
	ŌĒ	A	V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.7		6.2				
PZH PZL			V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.5		5.2	ns			
PZL			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.3		4.1				
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	0.3		3.6				
			V <sub>CCB</sub> = 1.2 V		2.3					
	ŌĒ		$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	0.4		4.5	ns			
t <sub>PZH</sub> t <sub>PZL</sub>		В	$V_{CCB} = 1.8 \text{ V} \pm 0.15 \text{ V}$	0.4		4.5				
YPZL			V <sub>CCB</sub> = 2.5 V ± 0.2 V 0.4			4.5				
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	0.4		4.5				
			V <sub>CCB</sub> = 1.2 V		3					
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.2		4.3				
t <sub>PHZ</sub> t <sub>PLZ</sub>	ŌĒ	Α	$V_{CCB} = 1.8 \text{ V} \pm 0.15 \text{ V}$	0.1		4.9	ns			
PLZ			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	0.1		4				
			$V_{CCB} = 3.3 \text{ V} \pm 0.3 \text{ V}$	0.7		4.3				
			V <sub>CCB</sub> = 1.2 V		1.9		-			
			$V_{CCB} = 1.5 \text{ V} \pm 0.1 \text{ V}$	01		4.7				
PHZ PLZ	ŌĒ	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		4.6	ns			
·FLZ			$V_{CCB} = 2.5 \text{ V} \pm 0.2 \text{ V}$	0.1		4.7				
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		4.7				



## 7.11 Switching Characteristics $V_{CCA} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range,  $V_{CCA}$  = 3.3 V ± 0.3 V (see Figure 3)

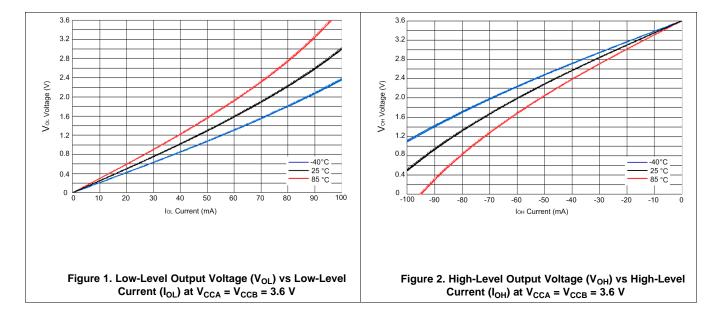
PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT				
			V <sub>CCB</sub> = 1.2 V		2.5						
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		3.6					
t <sub>PLH</sub> t <sub>PHL</sub>	Α	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		3	ns				
			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		2.6					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		2.4					
			V <sub>CCB</sub> = 1.2 V		2.6						
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.5							
t <sub>PLH</sub>	В	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.2		2.9	ns				
t <sub>PHL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		2.5					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		2.3					
			V <sub>CCB</sub> = 1.2 V		4.5						
	ŌĒ	A	V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.9		5.9					
t <sub>PZH</sub>			V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.5		5	ns				
t <sub>PZL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.3		3.8					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.3		3.3					
			V <sub>CCB</sub> = 1.2 V		1.9						
	ŌĒ		V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.4		3.6	ns				
t <sub>PZH</sub>		В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.4		3.6					
t <sub>PZL</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.4		3.6					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.4		3.6					
			V <sub>CCB</sub> = 1.2 V		2.7						
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		4.2					
t <sub>PHZ</sub>	ŌĒ	Α	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		4.6	ns				
t <sub>PLZ</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.3		3.8					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.7		3.9					
			V <sub>CCB</sub> = 1.2 V		2.3						
			V <sub>CCB</sub> = 1.5 V ± 0.1 V	0.1		4.5					
t <sub>PHZ</sub>	ŌĒ	В	V <sub>CCB</sub> = 1.8 V ± 0.15 V	0.1		4.5	ns				
t <sub>PLZ</sub>			V <sub>CCB</sub> = 2.5 V ± 0.2 V	0.1		4.6					
			V <sub>CCB</sub> = 3.3 V ± 0.3 V	0.1		4.6					

Submit Documentation Feedback

Copyright © 2008–2017, Texas Instruments Incorporated

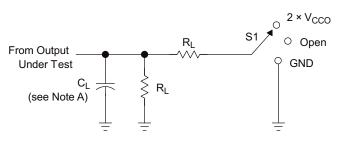


## 7.12 Typical Characteristics





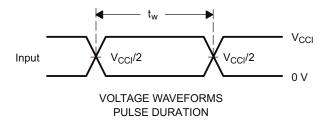
#### 8 Parameter Measurement Information

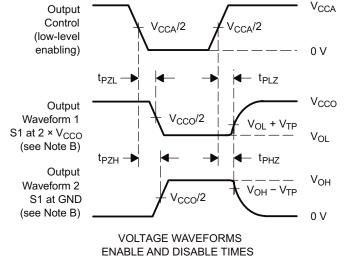


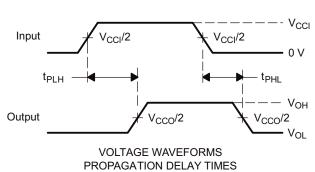
TEST	S1
t <sub>pd</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	2 × V <sub>CCO</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

LOAD CIRCUIT

V <sub>CCO</sub>	C <sub>L</sub>	$R_L$	V <sub>TP</sub>
1.2 V	15 pF	2 Ω	0.1 V
1.5 V ± 0.1 V	15 pF	2 Ω	0.1 V
1.8 V ± 0.15 V	15 pF	2 Ω	0.15 V
2.5 V ± 0.2 V	15 pF	2 Ω	0.15 V
3.3 V ± 0.3 V	15 pF	2 Ω	0.3 V







NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR 10 MHz, Z<sub>O</sub> = 50 W, dv/dt ≥ 1 V/ns.
- D. The outputs are measured one at a time, with one transition per measurement.
- E. t<sub>PLZ</sub> and t<sub>PHZ</sub> are the same as t<sub>dis</sub>.
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. V<sub>CCI</sub> is the V<sub>CC</sub> associated with the input port.
- I.  $V_{\text{CCO}}$  is the  $V_{\text{CC}}$  associated with the output port.

Figure 3. Load and Circuit and Voltage Waveforms

Submit Documentation Feedback



#### 9 Detailed Description

#### 9.1 Overview

The SN74AVC4T774 is a 4-bit, dual-supply, noninverting, bi-directional voltage level translation. Pins An and control pins (DIR1, DIR2, DIR3, DIR4 and  $\overline{OE}$ ) are support by  $V_{CCA}$  and pins Bn are support by  $V_{CCB}$ . The A port is able to accept I/O voltages ranging from 1.2 V to 3.6 V, while the B port can accept I/O voltages from 1.2 V to 3.6 V. A high on DIR allows data transmission from An to Bn and a low on DIR allows data transmission from B to A when  $\overline{OE}$  is set to low. When  $\overline{OE}$  is set to high, both An and Bn are in the high-impedance state.

#### 9.2 Functional Block Diagram

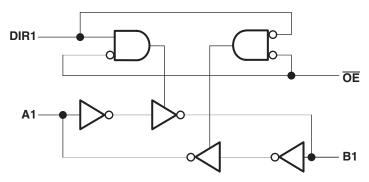


Figure 4. Logic Diagram (Positive Logic)

#### 9.3 Feature Description

# 9.3.1 Fully Configurable Dual-Rail Design Allows Each Port to Operate Over the Full 1.2-V to 3.6-V Power-Supply Range

Both  $V_{CCA}$  and  $V_{CCB}$  can be supplied at any voltage between 1.2 V and 3.6 V making the device suitable for translating between any of the low-voltage nodes (1.2 V, 1.8 V, 2.5 V and 3.3 V).

#### 9.3.2 Support High-Speed Translation

SN74AVC4T774 can support high data rate application. The translated signal data rate can be up to 380 Mbps when signal is translated from 1.8 V to 3.3 V.

#### 9.3.3 I<sub>off</sub> Supports Partial-Power-Down Mode Operation

Inf will prevent backflow current by disabling I/O output circuits when device is in partial-power-down mode.

#### 9.4 Device Functional Modes

Table 1. Function Table (Each Bit)

CONT	ROL INPUTS	OUTPUT (	OPERATION	
ŌĒ	DIR	A PORT	B PORT	OPERATION
L	L	Enabled	Hi-Z	B data to A data
L	Н	Hi-Z	Enabled	A data to B data
Н	X	Hi-Z	Hi-Z	Isolation



#### 10 Application and Implementation

#### **NOTE**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 10.1 Application Information

The SN74AVC4T774 device can be used in level-translation applications for interfacing devices or systems operating at different interface voltages with one another. The SN74AVC4T774 device is ideal for use in applications where a push-pull driver is connected to the data I/Os. Its max data rate can be up to 380 Mbps when device translate signal from 1.8 V to 3.3 V.

#### 10.2 Typical Application

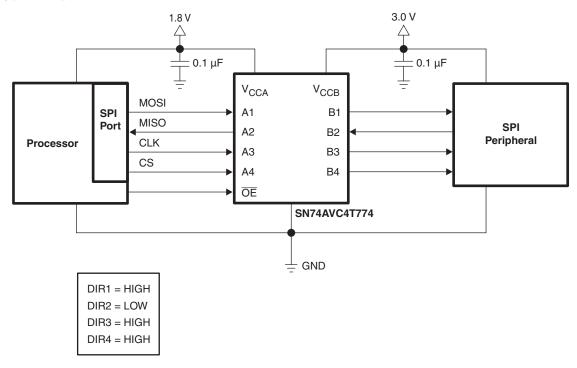


Figure 5. Typical Application of the SN74AVC4T774

#### 10.2.1 Design Requirements

For this design example, use the parameters listed in Table 2.

**Table 2. Design Parameters** 

DESIGN PARAMETERS	EXAMPLE VALUE
Input Voltage Range	1.2 V to 3.6 V
Output Voltage Range	1.2 V to 3.6 V



#### 10.2.2 Detailed Design Procedure

To begin the design process, determine the following:

- Input voltage range
  - Use the supply voltage of the device that is driving the SN74AVC4T774 device to determine the input voltage range. For a valid logic high, the value must exceed the  $V_{IH}$  of the input port. For a valid logic low, the value must be less than the  $V_{II}$  of the input port.
- Output voltage range
  - Use the supply voltage of the device that the SN74AVC4T774 device is driving to determine the output voltage range.

#### 10.2.3 Application Curve

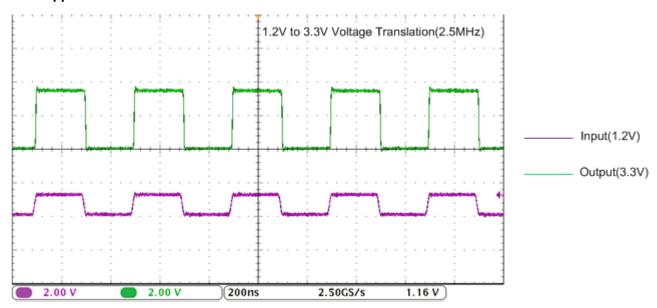


Figure 6. Translation Up (1.2 V to 3.3 V) at 2.5 MHz



### 11 Power Supply Recommendations

The SN74AVC4T774 device uses two separate configurable power-supply rails,  $V_{CCA}$  and  $V_{CCB}$   $V_{CCA}$  accepts any supply voltage from 1.2 V to 3.6 V and  $V_{CCB}$  accepts any supply voltage from 1.2 V to 3.6 V. The A port and B port are designed to track  $V_{CCA}$  and  $V_{CCB}$  respectively allowing for low-voltage, bi-directional translation between any of the 1.2-V, 1.5-V, 1.8-V, 2.5-V and 3.3-V voltage nodes.

The output-enable  $\overline{OE}$  input circuit is designed so that it is supplied by  $V_{CCA}$  and when the  $\overline{OE}$  input is high, all outputs are placed in the high-impedance state. To ensure the high-impedance state of the outputs during power-up or power-down, the OE input pin must be tied to V<sub>CCA</sub> through a pullup resistor and must not be enabled until V<sub>CCA</sub> and V<sub>CCB</sub> are fully ramped and stable. The minimum value of the pullup resistor to V<sub>CCA</sub> is determined by the current-sinking capability of the driver.

#### 12 Layout

#### 12.1 Layout Guidelines

To ensure reliability of the device, following common printed-circuit board layout guidelines are recommended:

- Bypass capacitors should be used on power supplies.
- Short trace lengths should be used to avoid excessive loading.
- Placing pads on the signal paths for loading capacitors or pullup resistors to help adjust rise and fall times of signals depending on the system requirements

Product Folder Links: SN74AVC4T774

Submit Documentation Feedback

Copyright © 2008-2017, Texas Instruments Incorporated



#### 12.2 Layout Example



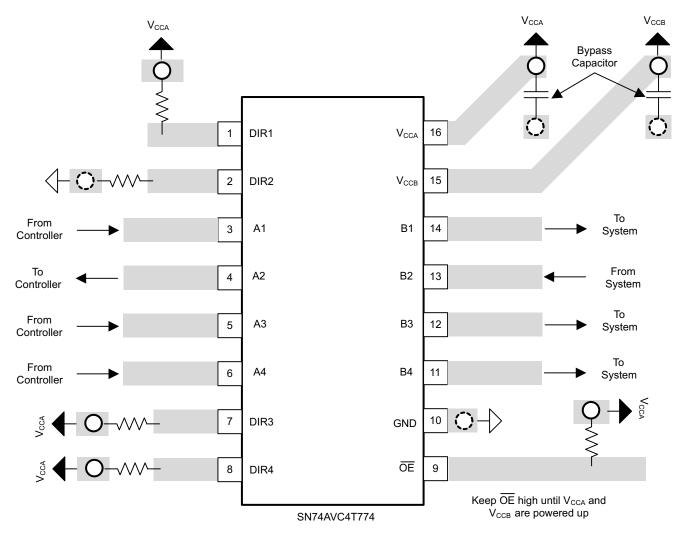


Figure 7. PCB Layout Example

Copyright © 2008–2017, Texas Instruments Incorporated

Submit Documentation Feedback



#### 13 Device and Documentation Support

#### 13.1 Documentation Support

#### 13.1.1 Related Documentation

For related documentation see the following:

- Understanding and Interpreting Standard-Logic Data Sheets
- Selecting the Right Level Translation Solution
- Introduction to Logic
- Solving CMOS Transition Rate Issues Using Schmitt Trigger Solution
- Voltage Translation Between 3.3-V, 2.5-V, 1.8-V, and 1.5-V Logic Standards
- Semiconductor Packing Material Electrostatic Discharge (ESD) Protection
- 16-Bit Widebus Logic Families in 56-Ball, 0.65-mm Pitch Very Thin Fine-Pitch BGA
- Dynamic Output Control (DOC) Circuitry Technology And Applications (Rev. B)
- AVC Logic Family Technology and Applications
- AVC Advanced Very-Low-Voltage CMOS Logic Data Book, March 2000
- Logic Guide
- TI Tablet Solutions
- LOGIC Pocket Data Book
- iLogic Cross-Reference
- LCD Module Interface Application Clip
- Standard Linear & Logic for PCs, Servers & Motherboards

#### 13.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 13.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support** *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 13.4 Trademarks

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

#### 13.5 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 13.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.



## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.





21-Dec-2018

#### **PACKAGING INFORMATION**

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
74AVC4T774RGYRG4	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT774	Samples
74AVC4T774RSVR-NT	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZVK	Samples
74AVC4T774RSVRG4	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZVK	Samples
SN74AVC4T774PW	ACTIVE	TSSOP	PW	16	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774PWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	WT774	Samples
SN74AVC4T774RGYR	ACTIVE	VQFN	RGY	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	WT774	Samples
SN74AVC4T774RSVR	ACTIVE	UQFN	RSV	16	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	ZVK	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.



## PACKAGE OPTION ADDENDUM

21-Dec-2018

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

**PACKAGE MATERIALS INFORMATION** 

www.ti.com 22-Dec-2018

#### TAPE AND REEL INFORMATION





	Dimension designed to accommodate the component width
	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
74AVC4T774RSVR-NT	UQFN	RSV	16	3000	180.0	8.4	2.0	2.8	0.7	4.0	8.0	Q1
SN74AVC4T774PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AVC4T774RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
SN74AVC4T774RSVR	UQFN	RSV	16	3000	178.0	13.5	2.1	2.9	0.75	4.0	12.0	Q1
SN74AVC4T774RSVR	UQFN	RSV	16	3000	180.0	12.4	2.1	2.9	0.75	4.0	12.0	Q1

www.ti.com 22-Dec-2018



\*All dimensions are nominal

7 til dilliciololio die Horilitai							
Device	Device Package Type		Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
74AVC4T774RSVR-NT	UQFN	RSV	16	3000	203.0	203.0	35.0
SN74AVC4T774PWR	TSSOP	PW	16	2000	367.0	367.0	35.0
SN74AVC4T774RGYR	VQFN	RGY	16	3000	367.0	367.0	35.0
SN74AVC4T774RSVR	UQFN	RSV	16	3000	189.0	185.0	36.0
SN74AVC4T774RSVR	UQFN	RSV	16	3000	203.0	203.0	35.0



SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



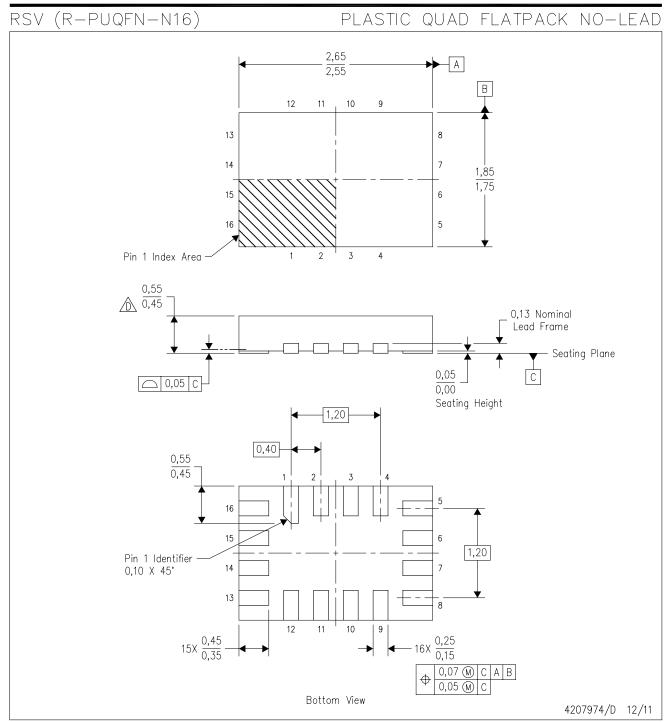
SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.





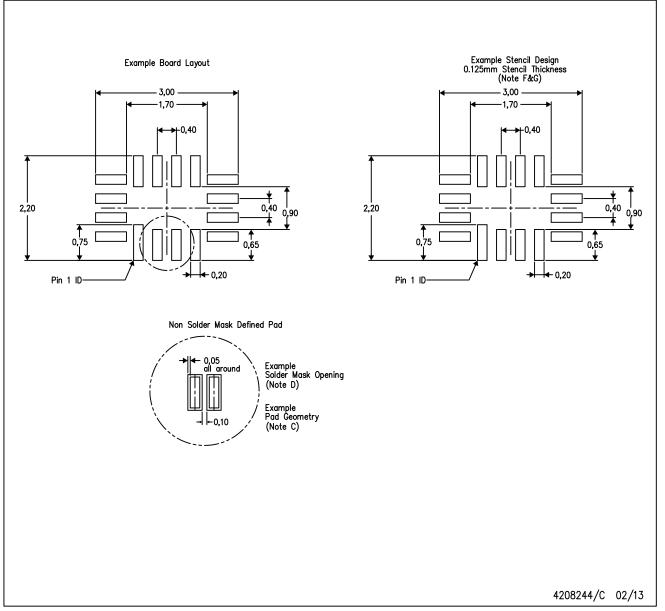
NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- This package complies to JEDEC MO-288 variation UFHE, except minimum package thickness.



## RSV (R-PUQFN-N16)

#### PLASTIC QUAD FLATPACK NO-LEAD



NOTES: A.

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.
- E. Maximum stencil thickness 0,127 mm (5 mils). All linear dimensions are in millimeters.
- F. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- G. Side aperture dimensions over—print land for acceptable area ratio > 0.66. Customer may reduce side aperture dimensions if stencil manufacturing process allows for sufficient release at smaller opening.





NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. QFN (Quad Flatpack No-Lead) package configuration.
- D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
- E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
- Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
- G. Package complies to JEDEC MO-241 variation BA.



## RGY (R-PVQFN-N16)

#### PLASTIC QUAD FLATPACK NO-LEAD

#### THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No—Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters



## RGY (R-PVQFN-N16)

## PLASTIC QUAD FLATPACK NO-LEAD



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat—Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <a href="https://www.ti.com">http://www.ti.com</a>.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
- F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (<a href="www.ti.com/legal/termsofsale.html">www.ti.com/legal/termsofsale.html</a>) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2018, Texas Instruments Incorporated